imall

Chipsmall Limited consists of a professional team with an average of over 10 year of expertise in the distribution of electronic components. Based in Hongkong, we have already established firm and mutual-benefit business relationships with customers from, Europe, America and south Asia, supplying obsolete and hard-to-find components to meet their specific needs.

With the principle of "Quality Parts, Customers Priority, Honest Operation, and Considerate Service", our business mainly focus on the distribution of electronic components. Line cards we deal with include Microchip, ALPS, ROHM, Xilinx, Pulse, ON, Everlight and Freescale. Main products comprise IC, Modules, Potentiometer, IC Socket, Relay, Connector. Our parts cover such applications as commercial, industrial, and automotives areas.

We are looking forward to setting up business relationship with you and hope to provide you with the best service and solution. Let us make a better world for our industry!



Contact us

Tel: +86-755-8981 8866 Fax: +86-755-8427 6832 Email & Skype: info@chipsmall.com Web: www.chipsmall.com Address: A1208, Overseas Decoration Building, #122 Zhenhua RD., Futian, Shenzhen, China



Chip Monolithic Ceramic Capacitor for General GRM0225C1C220JD05 (01005, C0G, 22pF, DC16V)

: packaging code

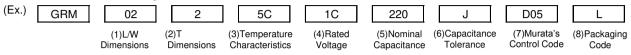
Reference Sheet

muRata

1.Scope

This product specification is applied to Chip Monolithic Ceramic Capacitor used for General Electronic equipment.

2.MURATA Part NO. System



3. Type & Dimensions



				(Unit:mm)
(1)-1 L	(1)-2 W	(2) T	e	g
0.4±0.02	0.2±0.02	0.2±0.02	0.07 to 0.14	0.13 min.

4.Rated value

	e Characteristics ode):C0G(EIA)	(4) Rated	(5) Nominal	(6) Capacitance	Specifications and Test Methods
Temp. coeff or Cap. Change	Temp. Range (Ref.Temp.)	Voltage	Capacitance	Tolerance	(Operating Temp. Range)
0±30 ppm/°C	25 to 125 °C (25 °C)	DC 16 V	22 pF	±5 %	-55 to 125 °C

5.Package

mark	(8) Packaging	Packaging Unit
L	∳180mm Reel EMBOSSED W4P1	40000 pcs./Reel

Product specifications in this catalog are as of Apr.12,2015, and are subject to change or obsolescence without notice. Please consult the approval sheet before ordering.

Please read rating and !Cautions first.

SPECIFICATIONS AND TEST METHODS

No	Itom		Specification	Toot Mothod
No	ltem	Temperature Compensating Type	High Dielectric Constant Type	Test Method
1	Operating Temperature Range	-55°C to 125°C	$\begin{array}{l} {\sf R6}:-55^\circ{\sf C}\ {\sf to}\ 85^\circ{\sf C}\\ {\sf R7}:-55^\circ{\sf C}\ {\sf to}\ 125^\circ{\sf C}\\ {\sf C8}:-55^\circ{\sf C}\ {\sf to}\ 105^\circ{\sf C}\\ {\sf E4}:10^\circ{\sf C}\ {\sf to}\ 85^\circ{\sf C}\\ {\sf F5}:-30^\circ{\sf C}\ {\sf to}\ 85^\circ{\sf C} \end{array}$	Reference Temperature : 25°C
2	Rated Voltage	See the previous pages.	L8, R9 : -55°C to 150°C	The rated voltage is defined as the maximum voltage which may be applied continuously to the capacitor. When AC voltage is superimposed on DC voltage. V ^{P-P} or V ^{O-P} , whichever is larger, should be maintained within the rated voltage range.
3	Appearance	No defects or abnormalities.		Visual inspection.
	Dimension	Within the specified dimensior	ns.	Using calipers. (GRM02 size is based on Microscope.)
	Dielectric Strength	No defects or abnormalities.	-	No failure should be observed when 300% of the rated voltage $(\Delta C \text{ to } 7U \text{ and } 1X) \text{ or } 250\%$ of the rated voltage (R6,R7,C8,E4,F5,L8 and R9 is applied between the terminations for 1 to 5 seconds, provided the charge/discharge current is less than 50mA.
-	Insulation Resistance	More than 10,000MΩ or 500Ω · (whichever is smaller)		The insulation resistance should be measured with a DC voltage not exceeding the rated voltage at 25°C and 75%RH max. and within 2 minutes of charging, provided the charge/discharge current is less than 50mA.
7	Capacitance	Within the specified tolerance.		The capacitance/Q/D.F. should be measured at 25°C at the frequency and voltage shown in the table.
8	Q/ Dissipation Factor (D.F.)	30pF and over:Q≧1000 30pF and below:Q≧400+20C C:Nominal Capacitance(pF)	$\label{eq:constraint} \begin{array}{l} [\text{R6}, \text{R7}, \text{C8}, \text{L8}] \\ \text{W.V.:100V : } 0.025 \text{max.} (\text{C} \leqslant 0.068 \mu\text{F}) \\ & : 0.05 \text{max.} (\text{C} \geqq 0.068 \mu\text{F}) \\ \text{W.V.:50V/25V : } 0.025 \text{max.} \\ \text{W.V.:61V/10V : } 0.035 \text{max.} \\ \text{W.V.:6.3V/4V : } 0.05 \text{max.} (\text{C} \leqslant 3.3 \mu\text{F}) \\ & : 0.1 \text{max.} (\text{C} \gtrless 3.3 \mu\text{F}) \\ \text{[R9]} \\ \text{W.V.:50V : } 0.05 \text{max.} \\ [\text{F4}] \\ \text{W.V.:25Vmin : } 0.025 \text{max.} \\ [\text{F5}] \\ \text{W.V.:25Vmin : } 0.05 \text{max.} (\text{C} \leqslant 0.1 \mu\text{F}) \\ & : 0.09 \text{max.} (\text{C} \gtrless 0.1 \mu\text{F}) \\ & : 0.01 \text{max.} (\text{C} \gtrless 0.1 \mu\text{F}) \\ \end{array}$	(1)Temperature Compensating Type Capacitance Frequency Voltage C≤1000pF 1±0.1MHz 0.5 to 5Vrms C>1000pF 1±0.1KHz 1±0.2Vrms (2)High Dielectric Constant Type Capacitance Frequency Voltage C≤100µF 1±0.1KHz 1±0.2Vrms C≤10µF 1±0.1KHz 1±0.2Vrms C>10µF 120±24Hz 0.5±0.1Vrms E4 1±0.1KHz 0.5±0.05Vrms
9	Capacitance No bias Temperature Characteristics	Within the specified tolerance.(Table A-1) Capacitance Drift * Within ±0.2% or ±0.05pF (Whichever is larger.) *Not apply to 1X/25V	R6 : Within ±15% (-55°C to +85°C) R7 : Within ±15% (-55°C to +125°C) C8 : Within ±22% (-55°C to +105°C) L8 : Within ±15% (-55°C to +125°C) : Within +15/-40% (+125°C to +150°C) R9 : Within ±15% (-55°C to +150°C) E4 : Within ±22/-56% (+10°C to +85°C) F5 : Within +22/-82% (-30°C to +85°C)	The capacitance change should be measured after 5min. at each specified temp. stage. (1)Temperature Compensating Type The capacitance drift is calculated by dividing the differences between the maximum and minimum measured values in the step 1,3 and 5 by the cap. value in step 3. $\frac{1}{1} \frac{25+2}{2} \frac{1}{2} \frac{1}{$
10 Adhesive Strength No of Termination		No removal of the termination:	s or other defect should occur.	then set for 24±2 hours at room temperature. Perform the initial measurement. Solder the capacitor on the test jig(glass epoxy board) shown in Fig.3 using a eutectic solder. Then apply 10N* force in parallel with the test jig for 10±1sec. The soldering should be done either with an iron or using the reflow method and should be conducted with care so that the soldering is uniform and free of defects such as heat shock. *1N(GRM02), 2N(GRM03), 5N(GRM15,GRM18)

SPECIFICATIONS AND TEST METHODS

				specification				
No	lt	em	Temperature	High Dielectric	1	Te	st Method	
11	Vibration	Appearance	Compensating Type No defects or abnormalities.	Constant Type	Solder the	capacitor on the test jig(alass enoxy h	oard) shown in Fig 3
1''	Resistance	, ippoaranud	abiotica of abiotimalities.			tectic solder.	лаза с роху D	oardy showin in Fig.s
		Capacitance	Within the specified tolerance.		The capacitor should be subjected to a simple harmonic motion having a total amplitude of 1.5mm, the frequency being varied uniformly between			
		Q/D.F.	30pF and over:Q≧1000	[R6,R7,C8,L8]		nate limits of 10 and 55Hz.	luency being	vaneu uniionniy between
			30pF and beloow:Q≧400+20C	W.V.:100V : 0.025max.(C<0.068µF)		ency range, from 10 to 55		
			C:Nominal Capacitance(pF)			in approximately 1 minute f 2 hours in each 3 mutua		
				W.V.:16V/10V : 0.035max.	(total of 6	hours).		
				W.V.:6.3V/4V : 0.05max. (C<3.3μF) : 0.1max.(C≧3.3μF)				
				[R9]				
				W.V.:50V : 0.05max.				
				[E4] W.V.:25V : 0.025max.				
				[F5]				
				W.V.:25Vmin : 0.05max. (C<0.1µF) : 0.09max.(C≧0.1µF)				
				W.V.:16V/10V : 0.125max.				
12	Deflection	Appearance	No defects or abnormalities.	W.V.:6.3V : 0.15max.	Solder the	capacitor on the test jig(alass epoxy h	oard) shown in Fig.1
.~	20.00000			1	using an e	utectic solder.	, , ,	, 3
		Capacitance Change	Within ±5% or± 0.5pF (Whichever is larger)	Within ±10%		y a force in the direction s ring should be done by the	•	
ĺ		Shange	(***iionever is larger)			with care so that the solo		
10	Coldon-Lill		750/ of the territoria is the	a coldered events and continues.	such as he	eat shock.		
13	Solderability of Termination		15% of the terminations is to b	e soldered evenly and continuously.		he capacitor in a solution K-5902) (25% rosin in we		
					Preheat a	80 to 120°C for 10 to 30	seconds.	,
						eating , immerse in an eutonds at 230±5°C or Sn-3.		
						seconds at 245±5°C.	- J	
14	Resistance		The measured and observed		<grm03< td=""><td></td><td>°</td><td></td></grm03<>		°	
	Soldering H	dering Heat the specifications in the follow		ing table.	Preheat the capacitor at 120 to 150°C for 1 min.(GRM31 size max.) Preheat the capacitor at 100 to 120°C for 1 min and			
		Appearance	No defects or abnormalities.	-	170 to 200	°C for 1 min.(GRM32 size	e min.)	
		Capacitance Change	Within $\pm 2.5\%$ or ± 0.25 pF (Whichever is larger)	R6,R7,R9,C8,L8 : Within ±7.5% E4,F5 : Within ±20%	Immerse the capacitor in an eutectic solder solution or Sn- $3.0Ag$ -0.5Cu solder solution at 270 \pm 5°C for 10 \pm 0.5 seconds.			
		Q/D.F.	30pF and over:Q≧1000	[R6,R7,C8,L8]	-	Set at room temperature for 24±2 hours, then measure.		
		30pF and beloow:Q≧400+20C	W.V.:100V : 0.025max.(C<0.068µF)		 Initial measurement for high dielectric constant type Perform a heat treatment at 150+0/-10°C for one hour and then set 			
			C:Nominal Capacitance(pF)	: 0.05max.(C≧0.068µF) W.V.:50V/25V : 0.025max.		mperature for 24±2 hours		e nour and then set
			· · · · · · · · · · · · · · · · · · ·	W.V.:16V/10V : 0.035max.		e initial measurement.		
				W.V.:6.3V/4V : 0.05max. (C<3.3µF) : 0.1max.(C≧3.3µF)	<grm02< td=""><td>size only></td><td></td><td></td></grm02<>	size only>		
				[R9]	Set the ca	pacitor by reflow soldering		
				W.V.:50V : 0.05max. [E4]		0.5Cu solder. Preheat the 1 minute by use of hot pla		
				W.V.:25V : 0.025max.		0±5°C for 10±0.5 second		
				[F5] W.V.:25Vmin : 0.05max. (C<0.1μF)		m temperature for 24±2 h asurement for high dieled		
			: 0.09max.(C≧0.1µF)		heat treatment at 150+0/			
				W.V.:16V/10V : 0.125max.		mperature for 24±2 hours	S.	
		I.R.	More than 10,000M Ω or 500 Ω	W.V.:6.3V : 0.15max. PF(Whichever is smaller)	Perform tr	e initial measurement.		
		Dielectric	No defects.	,	1			
15	Temperature	Strength e Cycle	The measured and observed of	characteristics should satisfy	Solder the	capacitor on the test jig(g	glass epoxy h	oard) shown in Fia.3
		-	the specifications in the follow		using an e	utectic solder.		
		Appearance	No defects or abnormalities.			e five cycles according to wing table.	o the tour hea	t treatments shown
						±2 hours at room tempera	ature, then me	easure.
		Capacitance Change	Within $\pm 2.5\%$ or ± 0.25 pF (Whichever is larger)	R6,R7,R9,C8,L8 : Within ±7.5% E4,F5 : Within ±20%	Step	Temp.(°C)	Time (min)	1
		Q/D.F.	30pF and over:Q≧1000	[R6,R7,C8,L8]	1	Min. Operating Temp.+0/-3	30±3	ļ
			30pF and beloow:Q≧400+20C	W.V.:100V : 0.025max.(C<0.068µF) : 0.05max.(C≧0.068µF)	2	Room Temp	2 to 3	ļ
			C:Nominal Capacitance(pF)	W.V.:50V/25V : 0.025max.	3	Max. Operating Temp.+3/-0	30±3	1
				W.V.:16V/10V : 0.035max. W.V.:6.3V/4V : 0.05max. (C<3.3μF)	4	Room Temp	2 to 3	ļ
				w.v.:6.3v/4v : 0.05max. (C<3.3μF) : 0.1max.(C≧3.3μF)	· Initial me	asurement for high dielec	tric constant	type
				[R9]		heat treatment at 150+0		e hour and then set
				W.V.:50V : 0.05max. [E4]		emperature for 24±2 hour he initial measurement.	5.	
				W.V.:25V : 0.025max.				
				[F5] W.V.:25Vmin : 0.05max. (C<0.1μF)				
				: 0.09max.(C≧0.1µF)				
				W.V.:16V/10V : 0.125max.				
		I.R.	More than 10,000MΩ or 500Ω	W.V.:6.3V : 0.15max. PF(Whichever is smaller)	-			
		Dielectric	No defects.	/	1			
l I		Strength						

■SPECIFICATIONS AND TEST METHODS

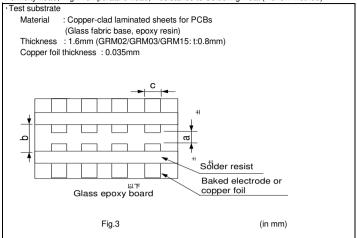
			Sp	ecification	
No		em	Temperature Compensating Type	High Dielectric Constant Type	Test Method
16	Humidity (Steady	L.	The measured and observed cha the specifications in the following		Solder the capacitor on the test jig(glass epoxy board) shown in Fig.3 using an eutectic solder.
	Appearance Capacitance Change Q/D.F.		No defects or abnormalities. Within $\pm 5\%$ or ± 0.5 pF (Whichever is larger)	R6,R7,R9,C8,L8 : Within ±12.5% E4,F5 : Within ±30%	Set the capacitor at 40±2°C and in 90 to 95% humidity for 500±12 hours. Remove and set for 24±2 hours at room temperature, then measure.
		Q/D.F.	30pF and over: Q≧350 10pF and over 30pF and below: Q≧275+5C/2 10pF and below: Q≧200+10C C:Nominal Capacitance(pF)	$\label{eq:response} \begin{split} & [R6,R7,R9,C8,L8] \\ & W.V.:100V: 0.05max.(C < 0.068\muF) \\ & \ldots 0.075max.(C \geq 0.068\muF) \\ & W.V.:50V/2SV: 0.05max. \\ & W.V.:16V/10V: 0.05max. \\ & W.V.:63V/VV: 0.075max.(C < 3.3\muF) \\ & : 0.125max.(C \geq 3.3\muF) \\ & [R9] \\ & W.V.:50V: 0.075max. \\ & [E4] \\ & W.V.:25V: 0.05max. \\ & [F5] \\ & W.V.:2SVmin: 0.075max.(C < 0.1\muF) \\ & : 0.12Smax.(C \geq 0.1\muF) \\ & W.V::5V/10V: 0.15max. \\ & W.W.W.W.W \\ & W.W.W \\ & W.W \\ & W \\ & W \\ & W.W \\ & W \\ & W$	
		I.R.	More than 1,000M Ω or 50 Ω ·F(W		_
17	Humidity Loa	Appearance	The measured and observed cha the specifications in the following No defects or abnormalities.		Solder the capacitor on the test jig(glass epoxy board) shown in Fig.3 using an eutectic solder.
		Capacitance Change	Within $\pm 7.5\%$ or ± 0.75 pF (Whichever is larger)	R6,R7,R9,C8,L8 : Within ±12.5% E4 : Within ±30% F5 : Within ±30%(W.V.>10V) F5 : Within ±30/40%(W.V.≤10V)	Apply the rated voltage at 40±2°C and 90 to 95% humidity for 500±12 hours. Remove and set for 24±2 hours at room temperature, then measure. The charge/discharge current is less than 50mA.
		Q/D.F. I.R.	30pF and over: Q≧200 30pF and below: Q≧100+10C/3 C:Nominal Capacitance(pF) More than 500MΩ or 25Ω·F(White	[R6,R7,R9,C8,L8] W.V.:100V : 0.05max.(C≥0.068μF) : 0.075max.(C≥0.068μF) W.V.:50V/25V : 0.05max. W.V.:16V/10V : 0.05max. W.V.:6.3V/4V : 0.075max.(C<3.3μF) : 0.125max.(C≥3.3μF) [R9] W.V.:50V : 0.075max. [F4] W.V.:25V : 0.05max. [F5] W.V.:25Vmin : 0.075max. (C<0.1μF) : 0.125max. (C<0.1μF) W.V.:16V/10V : 0.15max. W.V.:6.3V : 0.2max.	Initial measurement for F5/10Vmax. Apply the rated DC voltage for 1 hour at 40±2°C. Remove and set for 24±2 hours at room temperature. Perform initial measurement.
18	High Temper Load	the specifications in the following table.			Solder the capacitor on the test jig(glass epoxy board) shown in Fig.3 using an eutectic solder.
		Appearance Capacitance Change Q/D.F.	No defects or abnormalities. Within ±3% or ±0.3pF (Whichever is larger) 30pF and over: Q≧350 10pF and over 30pF and below: Q≧275+5C/2 10pF and below: Q≧200+10C C:Nominal Capacitance (pF)	$\begin{array}{l} \text{R6,R7,R9,C8,L8:Within \pm 12.5\%} \\ \text{E4} ::Within \pm 30\% \\ \text{F5} ::Within \pm 30\%(Cap<1.0 \ \mu\text{F}) \\ \text{F5} ::Within+30/-40\%(Cap\geq1.0 \ \mu\text{F}) \\ [R6,R7,R9,C8,L8] \\ \text{W.V.:100V: 0.05max.}(C < 0.068 \ \mu\text{F}) \\ :: 0.075max.(C \geq 0.068 \ \mu\text{F}) \\ :: 0.075max.(C \geq 0.068 \ \mu\text{F}) \\ :: 0.16V/10V: 0.05max. \\ \text{W.V.:50V/25V: 0.05max.} \\ \text{W.V.:6.3V/4V: 0.075max.}(C < 3.3 \ \mu\text{F}) \\ :: 0.125max.(C \geq 3.3 \ \mu\text{F}) \\ [R9] \\ \text{W.V.:50V: 0.075max.} \\ [E4] \\ \text{W.V.:25V: 0.05max.} \\ [F5] \\ \text{W.V.:25Vmin: 0.075max.} (C < 0.1 \ \mu\text{F}) \\ : 0.125max. (C \geq 0.1 \ \mu\text{F}) \\ : 0.125max. (C \geq 0.1 \ \mu\text{F}) \\ W.V.:6V/10V: 0.15max.} \end{array}$	Apply 200% of the rated voltage at the maximum operating temperature ±3°C for 1000±12 hours. Set for 24±2 hours at room temperature, then measure. The charge/discharge current is less than 50mA. -Initial measurement for high dielectric constant type. Apply 200% of the rated DC voltage at the maximum operating temperature ±3°C for one hour. Remove and set for 24±2 hours at room temperature. Perform initial measurement.
				W.V.:6.3V : 0.2max.	

Table A-1

Table A-T	-							
	Nominal	Capacitance Change from 25°C (%)						
Char.	Values	ues -55		5 -30		-1	10	
	(ppm/°C) *	Max.	Min.	Max.	Min.	Max.	Min.	
5C	0±30	0.58	-0.24	0.40	-0.17	0.25	-0.11	
6C	0±60	0.87	-0.48	0.59	-0.33	0.38	-0.21	
6P	-150± 60	2.33	0.72	1.61	0.50	1.02	0.32	
6R	-220± 60	3.02	1.28	2.08	0.88	1.32	0.56	
6S	-330± 60	4.09	2.16	2.81	1.49	1.79	0.95	
6T	-470± 60	5.46	3.28	3.75	2.26	2.39	1.44	
7U	-750±120	8.78	5.04	6.04	3.47	3.84	2.21	
1X	+350~-1000	-	-	-	-	-	-	

SPECIFICATIONS AND TEST METHODS

Adhesive Strength of Termination, Vibration Resistance, Temperature Cycle, Humidity, Humidity Load, High Temperature Load, Resistance to Soldering Heat (Reflow method)



Turna	Dimension (mm)					
Туре	а	b	с			
GRM02	0.2	0.56	0.23			
GRM03	0.3	0.9	0.3			
GRM15	0.4	1.5	0.5			
GRM18	1.0	3.0	1.2			
GRM21	1.2	4.0	1.65			
GRM31	2.2	5.0	2.0			
GRM32	2.2	5.0	2.9			
GRM43	3.5	7.0	3.7			
GRM55	4.5	8.0	5.6			

: Copper-clad laminated sheets for PCBs

(Coat with heat resistant resin for solder)

4

(in mm)

φ**4**.5

φ

(Glass fabric base, epoxy resin) Thickness : 1.6mm (GRM02/GRM03/GRM15: t:0.8mm)

Test method : Deflection •Test substrate

ラント

 \bigcirc

Copper foil thickness : 0.035mm

Gray colored part of Fig.1: Solder resist

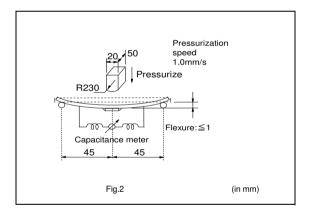
Land

a

100

Fig.1

Material



Turne	Dimension (mm)				
Туре	а	b	с		
GRM02	0.2	0.56	0.23		
GRM03	0.3	0.9	0.3		
GRM15	0.4	1.5	0.5		
GRM18	1.0	3.0	1.2		
GRM21	1.2	4.0	1.65		
GRM31	2.2	5.0	2.0		
GRM32	2.2	5.0	2.9		
GRM43	3.5	7.0	3.7		
GRM55	4.5	8.0	5.6		

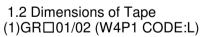
muRata

Package **GRM/F** Type

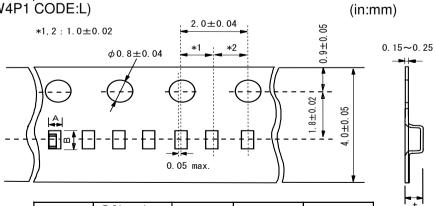
 \pm

1.Tape Carrier Packaging(Packaging Code:D/E/W/F/L/J/K) 1.1 Minimum Quantity(pcs./reel)

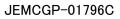
			φ180mm reel		φ330n	nm reel
	Туре	Pape	r Tape	Plastic Tape	Paper Tape	Plastic Tape
		Code:D/E	Code:W	Code:L	Code:J/ F	Code:K
GR□01				50000 (W4P1)		
GR□02				40000 (W4P1)		
GR□03		15000(W8P2)	30000(W8P1)		50000(W8P2)	
	2	20000(W8P2)			50000(W8P2)	
GR□15	3/X	10000(W8P2)			50000(W8P2)	
	5 (Dimensions Tolerance:±0.05)	10000(W8P2)	20000(W8P1)		50000(W8P2)	
	5 (Dimensions Tolerance:±0.1min.)	10000(W8P2)			40000(W8P2)	
GR□18		4000			10000	
	6	4000			10000	
GR□21	9	4000		3000	10000	10000
	A/B			3000		10000
	6/9	4000			10000	
GR□31	M/X			3000		10000
	С			2000		6000
	9	4000			10000	
	A/M			3000		10000
GR□32	N			2000		8000
	С			2000		6000
	R/D/E			1000		4000
	М			1000		5000
GR□43	N/R/D			1000		4000
GRU43	E			500		2000
	S			500		1500
	М			1000		5000
	N/C/R/D			1000		4000
GR□55	E			500		
	F			300		1500



*3 Nominal value



Туре	T Dimensions (Chip)	A *3	B *3	t	
GR□011	0.125±0.013	0. 145	0. 27	0.4 max.	
GR□022	0.2±0.02	0. 23	0. 43	0.5 max.	

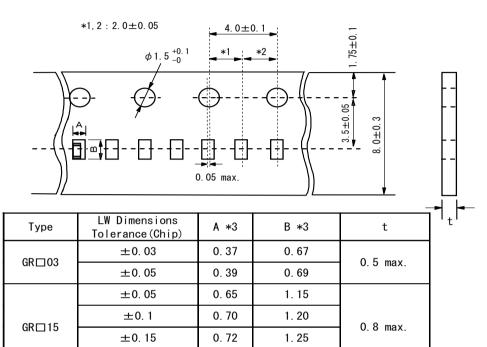


А

ш

Package GRM/F Type

(2)GRD03/15(W8P2 CODE:D/E/J/F)



0.75

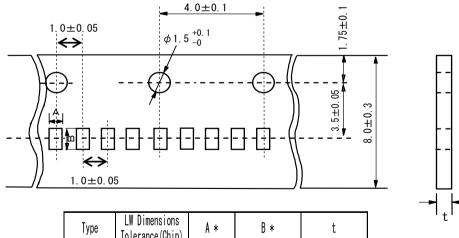
1.35

*3 Nominal value

(3)GRM033/155(W8P1 CODE:W)

±0.2

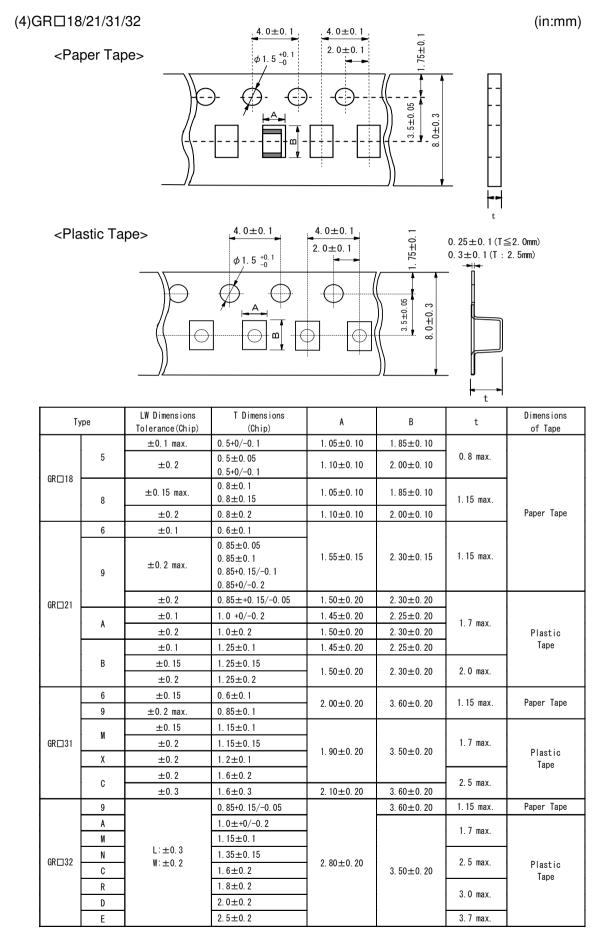
(in:mm)



Туре	LW Dimensions Tolerance(Chip)	A *	B *	t
GRM033	±0.03 ±0.05	0. 37	0.67	0. 5max.
GRM155	±0.05	0. 65	1.15	0. 8max.

* Nominal value

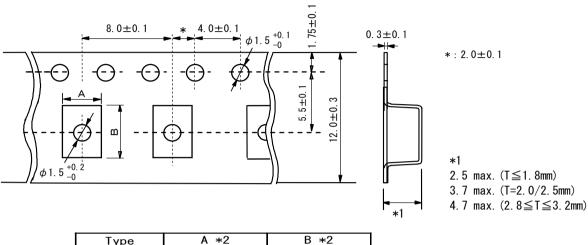




Package GRM/F Type

(5)GR□43/55

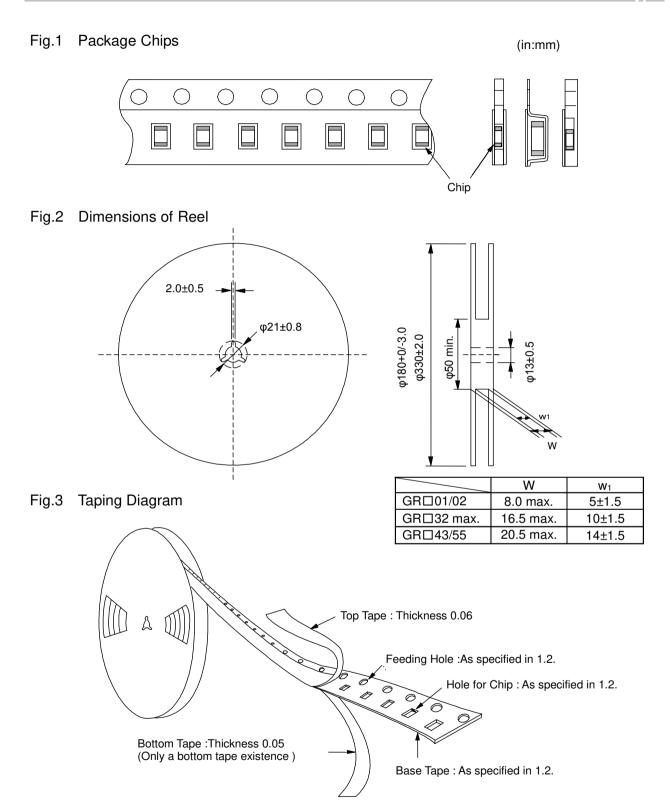
(in:mm)



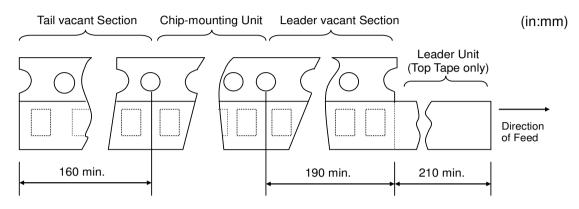
Туре	A *2	B *2
GR□43	3.60	4.90
GR□55	5. 20	6. 10

*2 Nominal value

Package GRM/F Type



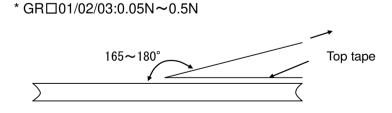
- 1.3 Tapes for capacitors are wound clockwise shown in Fig.3. (The sprocket holes are to the right as the tape is pulled toward the user.)
- 1.4 Part of the leader and part of the vacant section are attached as follows.



1.5 Accumulate pitch : 10 of sprocket holes pitch = 20 ± 0.3 mm(GR $\square 01/02$) 40 ±0.3 mm(GR $\square 03$ min.)

1.6 Chip in the tape is enclosed by top tape and bottom tape as shown in Fig.1.

- 1.7 The top tape and base tape are not attached at the end of the tape for a minimum of 5 pitches.
- 1.8 There are no jointing for top tape and bottom tape.
- 1.9 There are no fuzz in the cavity.
- 1.10 Break down force of top tape : 5N min. Break down force of bottom tape : 5N min. (Only a bottom tape existence)
- 図 チップ語あ我聽l is made by resin and appeaser and dimer範留: is shown in Fig 2. There are possibly to change the material and dimension due to some impairment.
 - 1.12 Peeling off force : 0.1N to $0.6N^{*}$ in the direction as shown below.



1.13 Label that show the customer parts number, our parts number, our company name, inspection number and quantity, will be put in outside of reel.

Limitation of Applications

Please contact us before using our products for the applications listed below which require especially high reliability for the prevention of defects which might directly cause damage to the third party's life, body or property.

①Aircraft equipment
 ②Aerospace equipment
 ③Undersea equipment
 ④Power plant control equipment
 ⑤Medical equipment
 ⑥Transportation equipment(vehicles,trains,ships,etc.)
 ⑦Traffic signal equipment
 ⑧Data-processing equipment
 ⑩Application of similar complexity and/or reliability requirements to the applications listed in the above.

Storage and Operation condition

1. The performance of chip monolithic ceramic capacitors may be affected by the storage conditions.

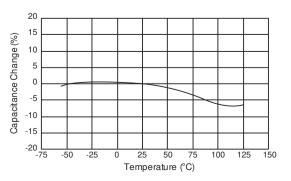
- 1-1. Store the capacitors in the following conditions: Room Temperature of +5°C to +40°C and a Relative Humidity of 20% to 70%.
 - Sunlight, dust, rapid temperature changes, corrosive gas atmosphere or high temperature and humidity conditions during storage may affect solderability and packaging performance. Therefore, please maintain the storage temperature and humidity. Use the product within six months, as prolonged storage may cause oxidation of the electrodes.
 - (2) Please confirm solderability before using after six months.
 Store the capacitors without opening the original bag.
 Even if the storage period is short, do not exceed the specified atmospheric conditions.
- 1-2. Corrosive gas can react with the termination (external) electrodes or lead wires of capacitors, and result in poor solderability. Do not store the capacitors in an atmosphere consisting of corrosive gas (e.g.,hydrogen sulfide, sulfur dioxide, chlorine, ammonia gas etc.).
- 1-3. Due to moisture condensation caused by rapid humidity changes, or the photochemical change caused by direct sunlight on the terminal electrodes and/or the resin/epoxy coatings, the solderability and electrical performance may deteriorate. Do not store capacitors under direct sunlight or in high huimidity conditions

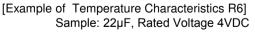
Rating

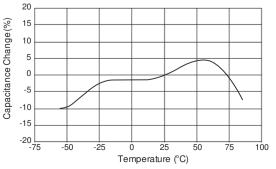
1.Temperature Dependent Characteristics

- 1. The electrical characteristics of the capacitor can change with temperature.
- 1-1. For capacitors having larger temperature dependency, the capacitance may change with temperature changes. The following actions are recommended in order to ensure suitable capacitance values.
 - (1) Select a suitable capacitance for the operating temperature range.
 - (2) The capacitance may change within the rated temperature. When you use a high dielectric constant type capacitors in a circuit that needs a tight (narrow) capacitance tolerance (e.g., a time-constant circuit), please carefully consider the temperature characteristics, and carefully confirm the various characteristics in actual use conditions and the actual system.

[Example of Temperature Caracteristics R7] Sample: 0.1µF, Rated Voltage 50VDC





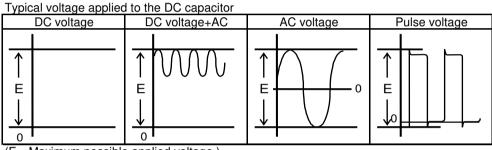


2.Measurement of Capacitance

- 1. Measure capacitance with the voltage and frequency specified in the product specifications.
- 1-1. The output voltage of the measuring equipment may decrease occasionally when capacitance is high. Please confirm whether a prescribed measured voltage is impressed to the capacitor.
- 1-2. The capacitance values of high dielectric constant type capacitors change depending on the AC voltage applied. Please consider the AC voltage characteristics when selecting a capacitor to be used in a AC circuit.

3.Applied Voltage

- 1. Do not apply a voltage to the capacitor that exceeds the rated voltage as called out in the specifications.
- 1-1. Applied voltage between the terminals of a capacitor shall be less than or equal to the rated voltage.
- (1) When AC voltage is superimposed on DC voltage, the zero-to-peak voltage shall not exceed the rated DC voltage. When AC voltage or pulse voltage is applied, the peak-to-peak voltage shall not exceed the rated DC voltage.
- (2) Abnormal voltages (surge voltage, static electricity, pulse voltage, etc.) shall not exceed the rated DC voltage.
- (2) Abnormal voltages (surge voltage, static electricity, puise voltage, etc.) shall not exceed the rated DC voltage



(E : Maximum possible applied voltage.)

1-2. Influence of over voltage

Over voltage that is applied to the capacitor may result in an electrical short circuit caused by the breakdown of the internal dielectric layers .

The time duration until breakdown depends on the applied voltage and the ambient temperature.

4.Type of Applied Voltage and Self-heating Temperature

1.Confirm the operating conditions to make sure that nolarge current is flowing into the capacitor due to the continuous application of an AC voltage or pulse voltage.

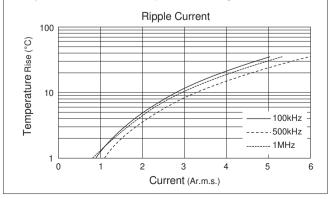
When a DC rated voltage product is used in an AC voltage circuit or a pulse voltage circuit, the AC current or pulse current will flow into the capacitor; therefore check the self-heating condition.

Please confirm the surface temperature of the capacitor so that the temperature remains within the upper limits of the operating temperature, including the rise in temperature due to self-heating. When the capacitor is used with a high-frequency voltage or pulse voltage, heat may be generated by dielectric loss.

<Applicable to Rated Voltage of less than 100VDC>

1-1. The load should be contained to the level such that when measuring at atmospheric temperature of 25°C, the product's self-heating remains below 20°C and the surface temperature of the capacitor in the actual circuit remains within the maximum operating temperature. [Example of Temperature Rise (Heat Generation) in Chip Monolithic Ceramic Capacitors in Contrast to Ripple Current]

Sample: R1 characteristics 10µF, Rated voltage: DC10V



5. DC Voltage and AC Voltage Characteristic

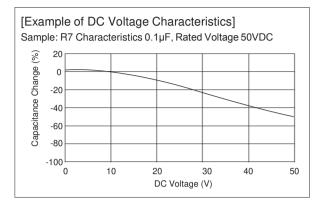
- 1. The capacitance value of a high dielectric constant type capacitor changes depending on the DC voltage applied. Please consider the DC voltage characteristics when a capacitor is selected for use in a DC circuit.
- 1-1. The capacitance of ceramic capacitors may change sharply depending on the applied voltage. (See figure) Please confirm the following in order to secure the capacitance.
- (1) Determine whether the capacitance change caused by the applied voltage is within the allowed range .
- (2) In the DC voltage characteristics, the rate of capacitance change becomes larger as voltage increases, even if the applied voltage is below the rated voltage. When a high dielectric constant type capacitor is used in a circuit that requires a tight (narrow) capacitance tolerance (e.g., a time constant circuit), please carefully consider the voltage characteristics, and confirm the various characteristics in actual operating conditions in an actual system.
- The capacitance values of high dielectric constant type capacitors changes depending on the AC voltage applied.
 Please consider the AC voltage characteristics when selecting a capacitor to be used in a AC circuit.

6. Capacitance Aging

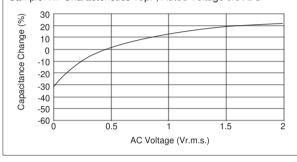
 The high dielectric constant type capacitors have the characteristic in which the capacitance value decreases with the passage of time.
 When you use a high dielectric constant type capacitors in a circuit that needs a tight (narrow) capacitance tolerance (e.g., a time-constant circuit), please carefully consider the characteristics of these capacitors, such as their aging, voltage, and temperature characteristics. In addition, check capacitors using your actual appliances at the intended environment and operating conditions.

7.Vibration and Shock

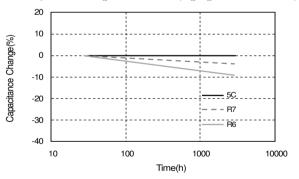
- 1. Please confirm the kind of vibration and/or shock, its condition, and any generation of resonance. Please mount the capacitor so as not to generate resonance, and do not allow any impact on the terminals.
- Mechanical shock due to being dropped may cause damage or a crack in the dielectric material of the capacitor. Do not use a fallen capacitor because the quality and reliability may be deteriorated.
- 3. When printed circuit boards are piled up or handled, the corner of another printed circuit board should not be allowed to hit the capacitor in order to avoid a crack or other damage to the capacitor.

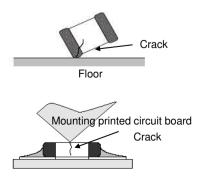






[Example of Change Over Time (Aging characteristics)]

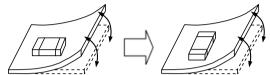




■Soldering and Mounting

1.Mounting Position

- 1. Confirm the best mounting position and direction that minimizes the stress imposed on the capacitor during flexing or bending the printed circuit board.
- 1-1.Choose a mounting position that minimizes the stress imposed on the chip during flexing or bending of the board. [Component Direction]

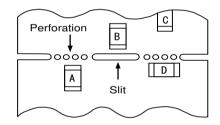


Locate chip horizontal to the direction in which stress acts.

[Chip Mounting Close to Board Separation Point]

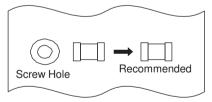
It is effective to implement the following measures, to reduce stress in separating the board. It is best to implement all of the following three measures; however, implement as many measures as possible to reduce stress.

Contents of Measures	Stress Level
(1) Turn the mounting direction of the component parallel to the board separation surface.	A > D
(2) Add slits in the board separation part.	A > B
(3) Keep the mounting position of the component away from the board separation surface.	A > C



[Mounting Capacitors Near Screw Holes]

When a capacitor is mounted near a screw hole, it may be affected by the board deflection that occurs during the tightening of the screw. Mount the capacitor in a position as far away from the screw holes as possible.



2.Information before Mounting

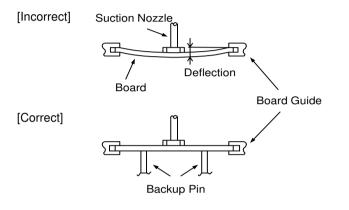
- 1. Do not re-use capacitors that were removed from the equipment.
- 2. Confirm capacitance characteristics under actual applied voltage.
- 3. Confirm the mechanical stress under actual process and equipment use.
- 4. Confirm the rated capacitance, rated voltage and other electrical characteristics before assembly.
- 5. Prior to use, confirm the solderability for the capacitors that were in long-term storage.
- 6. Prior to measuring capacitance, carry out a heat treatment for capacitors that were in long-term storage.
- 7. The use of Sn-Zn based solder will deteriorate the reliability of the MLCC. Please contact our sales representative or product engineers on the use of Sn-Zn based solder in advance.

32

 \bigcirc

3.Maintenance of the Mounting (pick and place) Machine

- 1. Make sure that the following excessive forces are not applied to the capacitors.
- 1-1. In mounting the capacitors on the printed circuit board, any bending force against them shall be kept to prevent them from any bending damage or cracking. Please take into account the following precautions and recommendations for use in your process.
 - (1) Adjust the lowest position of the pickup nozzle so as not to bend the printed circuit board.
 - (2) Adjust the nozzle pressure within a static load of 1N to 3N during mounting.



2. Dirt particles and dust accumulated between the suction nozzle and the cylinder inner wall prevent the nozzle from moving smoothly. This imposes greater force upon the chip during mounting, causing cracked chips. Also, the locating claw, when worn out, imposes uneven forces on the chip when positioning, causing cracked chips. The suction nozzle and the locating claw must be maintained, checked and replaced periodically.

4-1.Reflow Soldering

- 1. When sudden heat is applied to the components, the mechanical strength of the components will decrease because a sudden temperature change causes deformation inside the components. In order to prevent mechanical damage to the components, preheating is required for both the components and the PCB. Preheating conditions are shown in table 1. It is required to keep the temperature differential between the solder and the components surface (Δ T) as small as possible.
- 2. Solderability of tin plating termination chips might be deteriorated when a low temperature soldering profile where the peak solder temperature is below the melting point of tin is used. Please confirm the solderability of tin plated termination chips before use.
- 3. When components are immersed in solvent after mounting, be sure to maintain the temperature difference (ΔT) between the component and the solvent within the range shown in the table 1.

Table 1			
Part Number	Temperature Differential		
GRM01/02/03/15/18/21/31	ΔT≦190°C		
GRM32/43/55	ΔT≦130°C		

Recommended Conditions

	Lead Free Solder	
Peak Temperature	240 to 260°C	
Atmosphere	Air or N ₂	

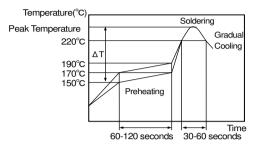
Lead Free Solder: Sn-3.0Ag-0.5Cu

4. Optimum Solder Amount for Reflow Soldering

- 4-1. Overly thick application of solder paste results in a excessive solder fillet height. This makes the chip more susceptible to mechanical and thermal stress on the board and may cause the chips to crack.
- 4-2. Too little solder paste results in a lack of adhesive strength on the outer electrode, which may result in chips breaking loose from the PCB.
- 4-3. Make sure the solder has been applied smoothly to the end surface to a height of 0.2mm* min.

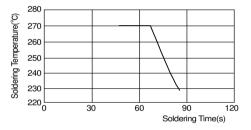
Inverting the PCB

Make sure not to impose any abnormal mechanical shocks to the PCB.

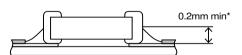


[Standard Conditions for Reflow Soldering]

[Allowable Reflow Soldering Temperature and Time]



In the case of repeated soldering, the accumulated soldering time must be within the range shown above.



*GRM01 : 1/2 of Chip Thickness min. GRM02/03: 1/3 of Chip Thickness min. in section

4-2.Flow Soldering

1. Do not apply flow soldering to chips not listed in Table 2.

Tab	ما	2
iau	5	<u> </u>

Part Number	Temperature Differential
GRM18/21/31	ΔT≦150°C

- 2. When sudden heat is applied to the components, the mechanical strength of the components will decrease because a sudden temperature change causes deformation inside the components. In order to prevent mechanical damage to the components, preheating is required for both of the components and the PCB. Preheating conditions are shown in table 2. It is required to keep the temperature differential between the solder and the components surface (ΔT) as low as possible.
- 3. Excessively long soldering time or high soldering temperature can result in leaching of the outer electrodes, causing poor adhesion or a reduction in capacitance value due to loss of contact between the electrodes and end termination.
- 4. When components are immersed in solvent after mounting, be sure to maintain the temperature differential (ΔT) between the component and solvent within the range shown in the table 2.

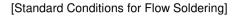
Recommended Conditions

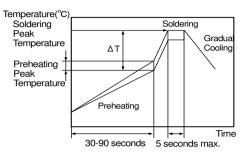
	Lead Free Solder
Preheating Peak Temperature	100 to 120°C
Soldering Peak Temperature	250 to 260°C
Atmosphere	Air

Lead Free Solder: Sn-3.0Ag-0.5Cu

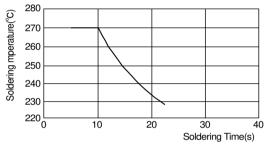
5. Optimum Solder Amount for Flow Soldering

5-1. The top of the solder fillet should be lower than the thickness of components. If the solder amount is excessive, the risk of cracking is higher during board bending or any other stressful condition.

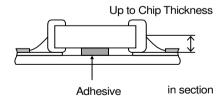




[Allowable Flow Soldering Temperature and Time]



In the case of repeated soldering, the accumulated soldering time must be within the range shown above.



4-3.Correction of Soldered Portion

When sudden heat is applied to the capacitor, distortion caused by the large temperature difference occurs internally, and can be the cause of cracks. Capacitors also tend to be affected by mechanical and thermal stress depending on the board preheating temperature or the soldering fillet shape, and can be the cause of cracks. Please refer to "1. PCB Design" or "3. Optimum solder amount" for the solder amount and the fillet shapes.

1. Correction with a Soldering Iron

- 1-1. In order to reduce damage to the capacitor, be sure to preheat the capacitor and the mounting board.
- Preheat to the temperature range shown in Table 3. A hot plate, hot air type preheater, etc. can be used for preheating. 1-2. After soldering, do not allow the component/PCB to cool down rapidly.
- 1-3. Perform the corrections with a soldering iron as quickly as possible. If the soldering iron is applied too long, there is a possibility of causing solder leaching on the terminal electrodes, which will cause deterioration of the adhesive strength and other problems.

Table 3	
---------	--

Part Number	Temperature of Soldering Iron tip	Preheating Temperature	Temperature Differential(ΔT)	Atmosphere
GRM03/15/18/21/31	350°C max.	150°C min.	ΔT≦190°C	Air
GRM32/43/55	280°C max.	150°C min.	ΔT≦130°C	Air

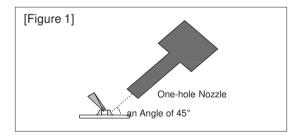
Lead Free Solder: Sn-3.0Ag-0.5Cu

2. Correction with Spot Heater

Compared to local heating with a soldering iron, hot air heating by a spot heater heats the overall component and board, therefore, it tends to lessen the thermal shock. In the case of a high density mounted board, a spot heater can also prevent concerns of the soldering iron making direct contact with the component.

- 2-1. If the distance from the hot air outlet of the spot heater to the component is too close, cracks may occur due to thermal shock. To prevent this problem, follow the conditions shown in Table 4.
- 2-2. In order to create an appropriate solder fillet shape, it is recommended that hot air be applied at the angle shown in Figure 1.

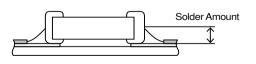
Table 4		
	Distance	5mm or more
	Hot Air Application angle	45° *Figure 1
	Hot Air Temperature Nozzle Outlet	400°C max.
		Less than 10 seconds
	Application Time	(1206 (in inch) / (3216 (in mm) size or smalle
		Less than 30 seconds
		(1210 (in inch) / 3225 (in mm) size or larger)



- 3. Optimum solder amount when re-working with a soldering iron
- 3-1. In the case of 0603 (in inch) / 1608 (in mm) and smaller sizes (GRM03/15/18), the top of the solder fillet should be lower than 2/3 of the thickness of the component or 0.5mm, whichever is smaller.

In the case of 0805 (in inch) / 2012(in mm) and larger sizes (GRM21/31/32/43/55), the top of the solder fillet should be lower than 2/3 of the thickness of the component. If the solder amount is excessive, the risk of cracking is higher during board bending or under any other stressful condition.

- 3-2. A soldering iron with a tip of ø3mm or smaller should be used. It is also necessary to keep the soldering iron from touching the components during the re-work.
- 3-3. Solder wire with ø0.5mm or smaller is required for soldering.



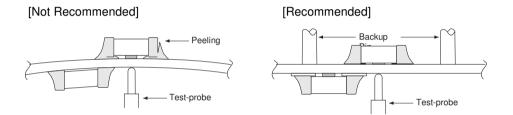
in section

5.Washing

Excessive ultrasonic oscillation during cleaning can cause the PCBs to resonate, resulting in cracked chips or broken solder joints. Take note not to vibrate PCBs.

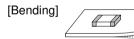
6.Electrical Test on Printed Circuit Board

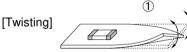
- 1. Confirm position of the backup pin or specific jig, when inspecting the electrical performance of a capacitor after mounting on the printed circuit board.
 - 1-1. Avoid bending the printed circuit board by the pressure of a test-probe, etc. The thrusting force of the test probe can flex the PCB, resulting in cracked chips or open solder joints. Provide backup pins on the back side of the PCB to prevent warping or flexing. Install backup pins as close to the test-probe as possible.
 - 1-2. Avoid vibration of the board by shock when a test -probe contacts a printed circuit board.



7.Printed Circuit Board Cropping

- 1. After mounting a capacitor on a printed circuit board, do not apply any stress to the capacitor that caused bending or twisting the board.
 - 1-1. In cropping the board, the stress as shown at right may cause the capacitor to crack. Cracked capacitors may cause deterioration of the insulation resistance, and result in a short. Avoid this type of stress to a capacitor.





- 2. Check the cropping method for the printed circuit board in advance.
 - 2-1. Printed circuit board cropping shall be carried out by using a jig or an apparatus (Disk separator, router type separator, etc.) to prevent the mechanical stress that can occur to the board.

Board Separation Method	Hand Separation Nipper Separation	(1) Board Separation Jig	Board Separation Apparatus	
			Disk Separator	3) Router Type Separator
Level of stress on board	High	Medium	Medium	Low
Recommended	×	Δ^*	Δ^*	0
	Hand and nipper separation apply a high level of stress. Use another method.	 Board handling Board bending direction Layout of capacitors 	 Board handling Layout of slits Design of V groove Arrangement of blades Controlling blade life 	Board handling

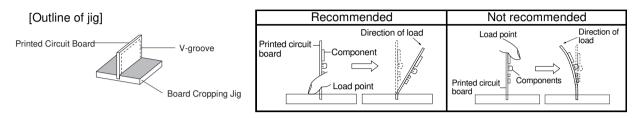
* When a board separation jig or disk separator is used, if the following precautions are not observed, a large board deflection stress will occur and the capacitors may crack. Use router type separator if at all possible.

(1) Example of a suitable jig

[In the case of Single-side Mounting]

An outline of the board separation jig is shown as follows.

Recommended example: Stress on the component mounting position can be minimized by holding the portion close to the jig, and bend in the direction towards the side where the capacitors are mounted. Not recommended example: The risk of cracks occurring in the capacitors increases due to large stress being applied to the component mounting position, if the portion away from the jig is held and bent in the direction opposite the side where the capacitors are mounted.



[In the case of Double-sided Mounting]

Since components are mounted on both sides of the board, the risk of cracks occurring can not be avoided with the above method. Therefore, implement the following measures to prevent stress from being applied to the components. (Measures)

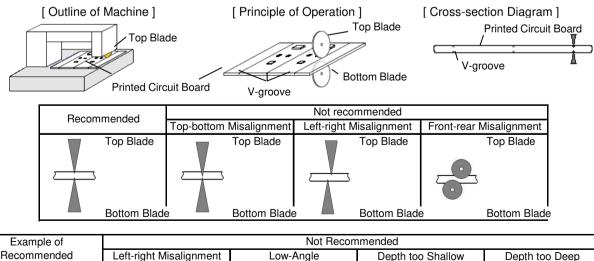
- (1) Consider introducing a router type separator.
 - If it is difficult to introduce a router type separator, implement the following measures. (Refer to item 1. Mounting Position)
- (2) Mount the components parallel to the board separation surface.
- (3) When mounting components near the board separation point, add slits in the separation position near the component.
- (4) Keep the mounting position of the components away from the board separation point.

(2) Example of a Disk Separator

An outline of a disk separator is shown as follows. As shown in the Principle of Operation, the top blade and bottom blade are aligned with the V-grooves on the printed circuit board to separate the board. In the following case, board deflection stress will be applied and cause cracks in the capacitors.

- (1) When the adjustment of the top and bottom blades are misaligned, such as deviating in the top-bottom, left-right or front-rear directions
- (2) The angle of the V groove is too low, depth of the V groove is too shallow, or the V groove is misaligned top-bottom

IF V groove is too deep, it is possible to brake when you handle and carry it. Carefully design depth of the V groove with consideration about strength of material of the printed circuit board.



			1001100001	intenaca	
	Recommended	Left-right Misalignment	Low-Angle	Depth too Shallow	Depth too Deep

muRata ∆Caution

(3) Example of Router Type Separator

The router type separator performs cutting by a router rotating at a high speed. Since the board does not bend in the cutting process, stress on the board can be suppressed during board separation. When attaching or removing boards to/from the router type separator, carefully handle the boards to prevent bending.

8. Assembly

1. Handling

If a board mounted with capacitors is held with one hand, the board may bend.

Firmly hold the edges of the board with both hands when handling.

If a board mounted with capacitors is dropped, cracks may occur in the capacitors.

Do not use dropped boards, as there is a possibility that the quality of the capacitors may be impaired.

2. Attachment of Other Components

2-1. Mounting of Other Components

Pay attention to the following items, when mounting other components on the back side of the board after capacitors have been mounted on the opposite side.

When the bottom dead point of the suction nozzle is set too low, board deflection stress may be applied to the capacitors on the back side (bottom side), and cracks may occur in the capacitors.

 \cdot After the board is straightened, set the bottom dead point of the nozzle on the upper surface of the board.

· Periodically check and adjust the bottom dead point.



2-2. Inserting Components with Leads into Boards

When inserting components (transformers, IC, etc.) into boards, bending the board may cause cracks in the capacitors or cracks in the solder. Pay attention to the following.

- · Increase the size of the holes to insert the leads, to reduce the stress on the board during insertion.
- \cdot Fix the board with backup pins or a dedicated jig before insertion.
- Support below the board so that the board does not bend. When using multiple backup pins on the board, periodically confirm that there is no difference in the height of each backup pin.

Component with Leads



2-3. Attaching/Removing Sockets

When the board itself is a connector, the board may bend when a socket is attached or removed. Plan the work so that the board does not bend when a socket is attached or removed.

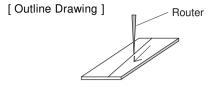


2-4. Tightening Screws

The board may be bent, when tightening screws, etc. during the attachment of the board to a shield or chassis. Pay attention to the following items before performing the work.

- · Plan the work to prevent the board from bending.
- · Use a torque screwdriver, to prevent over-tightening of the screws.
- The board may bend after mounting by reflow soldering, etc. Please note, as stress may be applied to the chips by forcibly flattening the board when tightening the screws.





Others

1. Under Operation of Equipment

- 1-1. Do not touch a capacitor directly with bare hands during operation in order to avoid the danger of an electric shock.
- 1-2. Do not allow the terminals of a capacitor to come in contact with any conductive objects (short-circuit). Do not expose a capacitor to a conductive liquid, inducing any acid or alkali solutions.
- 1-3. Confirm the environment in which the equipment will operate is under the specified conditions.
 - Do not use the equipment under the following environments.
 - (1) Being spattered with water or oil.
 - (2) Being exposed to direct sunlight.
 - (3) Being exposed to ozone, ultraviolet rays, or radiation.
 - (4) Being exposed to toxic gas (e.g., hydrogen sulfide, sulfur dioxide, chlorine, ammonia gas etc.)
 - (5) Any vibrations or mechanical shocks exceeding the specified limits.
 - (6) Moisture condensing environments.
- 1-4. Use damp proof countermeasures if using under any conditions that can cause condensation.

2. Others

- 2-1. In an Emergency
- (1) If the equipment should generate smoke, fire, or smell, immediately turn off or unplug the equipment. If the equipment is not turned off or unplugged, the hazards may be worsened by supplying continuous power.
- (2) In this type of situation, do not allow face and hands to come in contact with the capacitor or burns may be caused by the capacitor's high temperature.
- 2-2. Disposal of waste

When capacitors are disposed of, they must be burned or buried by an industrial waste vendor with the appropriate licenses.

- 2-3. Circuit Design
 - (1) Addition of Fail Safe Function

Capacitors that are cracked by dropping or bending of the board may cause deterioration of the insulation resistance, and result in a short. If the circuit being used may cause an electrical shock, smoke or fire when a capacitor is shorted, be sure to install fail-safe functions, such as a fuse, to prevent secondary accidents.

(2) The GRM series are not safety standard certified products.

2-4. Remarks

Failure to follow the cautions may result, worst case, in a short circuit and smoking when the product is used. The above notices are for standard applications and conditions. Contact us when the products are used in special mounting conditions.

Select optimum conditions for operation as they determine the reliability of the product after assembly. The data herein are given in typical values, not guaranteed ratings.

muRata Notice

Rating

1.Operating Temperature

- 1. The operating temperature limit depends on the capacitor.
- 1-1. Do not apply temperatures exceeding the upper operating temperature.
 It is necessary to select a capacitor with a suitable rated temperature that will cover the operating temperature range.
 It is also necessary to consider the temperature distribution in equipment and the seasonal temperature variable factor.
- 1-2. Consider the self-heating factor of the capacitor The surface temperature of the capacitor shall be the upper operating temperature or less when including the self-heating factors.

2.Atmosphere Surroundings (gaseous and liquid)

- 1. Restriction on the operating environment of capacitors.
- 1-1. Capacitors, when used in the above, unsuitable, operating environments may deteriorate due to the corrosion of the terminations and the penetration of moisture into the capacitor.
- 1-2. The same phenomenon as the above may occur when the electrodes or terminals of the capacitor are subject to moisture condensation.
- 1-3. The deterioration of characteristics and insulation resistance due to the oxidization or corrosion of terminal electrodes may result in breakdown when the capacitor is exposed to corrosive or volatile gases or solvents for long periods of time.

3.Piezo-electric Phenomenon

1. When using high dielectric constant type capacitors in AC or pulse circuits, the capacitor itself vibrates at specific frequencies and noise may be generated. Moreover, when the mechanical vibration or shock is added to capacitor, noise may occur.

■Soldering and Mounting

1.PCB Design

Dottorn Forma

- 1. Notice for Pattern Forms
- 1-1. Unlike leaded components, chip components are susceptible to flexing stresses since they are mounted directly on the substrate.
 They are also more sensitive to mechanical and thermal stresses than leaded components.
 Excess solder fillet height can multiply these stresses and cause chip cracking.
 When designing substrates, take land patterns and dimensions into consideration to eliminate the possibility of excess solder fillet height.
- 1-2. There is a possibility of chip cracking caused by PCB expansion/contraction with heat, because stress on a chip is different depending on PCB material and structure. When the thermal expansion coefficient greatly differs between the board used for mounting and the chip, it will cause cracking of the chip due to the thermal expansion and contraction. When capacitors are mounted on a fluorine resin printed circuit board or on a single-layered glass epoxy board, it may also cause cracking of the chip for the same reason.

	Prohibited	Correct
Placing Close to Chassis	Chassis Solder (ground) Electrode Pattern in section	Solder Resist
Placing of Chip Components and Leaded Components	Lead Wire	Solder Resist
Placing of Leaded Components after Chip Component	Soldering Iron Lead Wire	Solder Resist in section
Lateral Mounting	У№3* レジ*	Solder Resist